Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/808,532	TACHIBANA ET AL.	
Examiner	Art Unit	
Bao O Vu	2838	

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Class	Subclass	Date	Examiner
323	313	6/21/2005	BV
	314		
	315		
327	539		BV

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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